

Interpreting a successful testing process: risk and actual coverage

Mariëlle Stoelinga, **Mark Timmer**
University of Twente

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- 2 The WFS Model
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- 4 Other Applications
- 5 Limitations and Possibilities
- 6 Conclusions and Future Work

Why testing?

- Software becomes more and more complex
- Research showed that billions can be saved by testing better
- No need for the source code (black-box perspective)

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Model-based testing

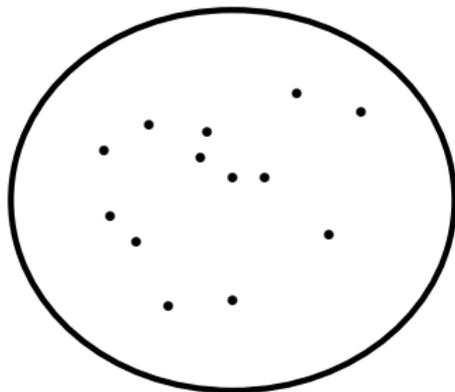
- Precise and formal
- Automatic generation and evaluations of tests
- Repeatable and scientific basis for product testing

Why do we need risk and coverage?

- Testing is inherently incomplete
- Testing does increase our confidence in the system
- A notion of *quality* of a test suite is necessary
- Two fundamental concepts: risk and coverage

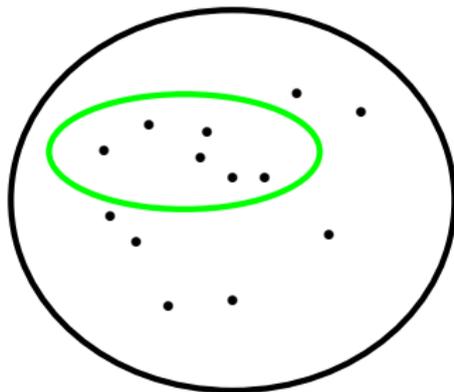
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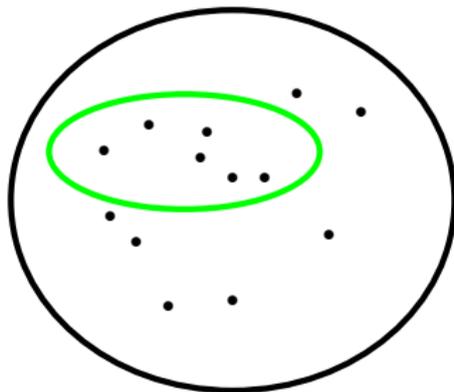
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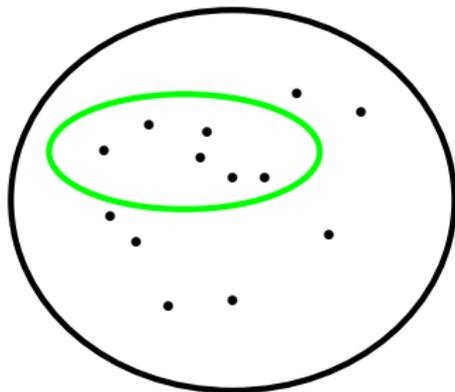
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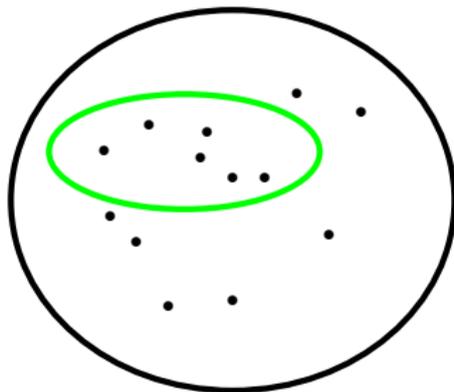


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$$\text{Coverage: } \frac{6}{13} = 46\%$$

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Informal calculation

$$\text{Coverage: } \frac{6}{13} = 46\%$$

$$\text{Risk: } 7 \cdot 0.1 \cdot \$10 = \$7$$

Existing coverage measures

- Statement coverage
- State/transition coverage

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Limitations:

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Limitations:

- Informal
- Based on heuristics
- Only identify testing order for components

Starting point: semantic coverage

Previous work by Brandán Briones, Brinksma and Stoelinga

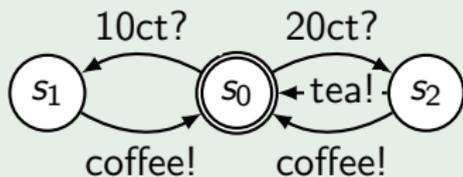
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Labelled transition systems

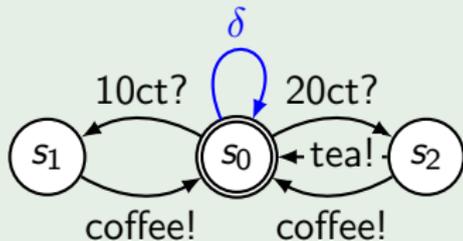


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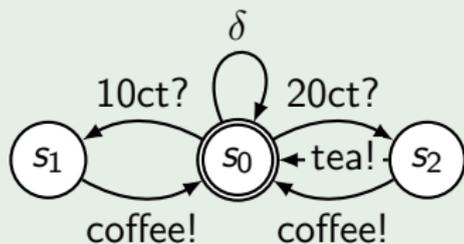


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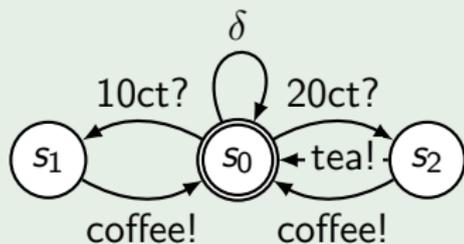
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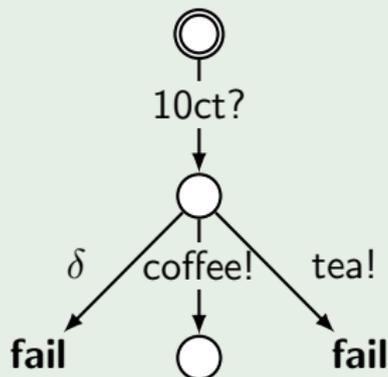
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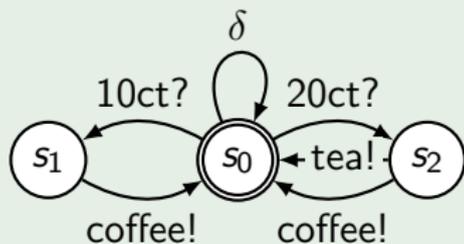


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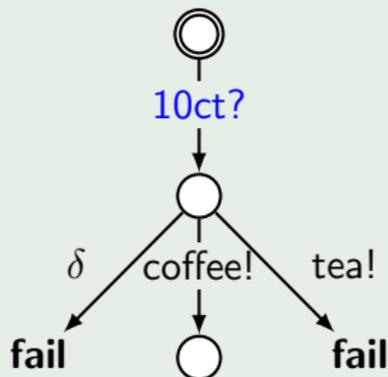
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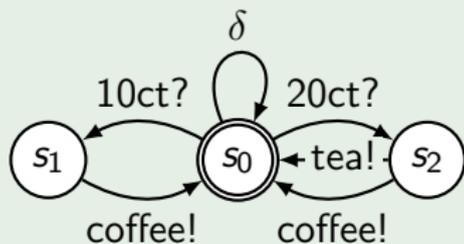


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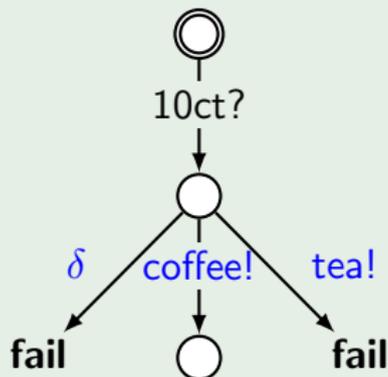
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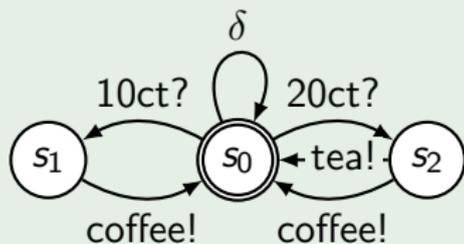


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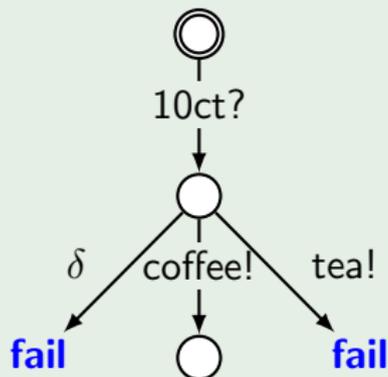
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Weighted fault specification

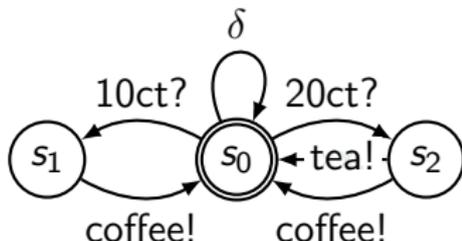
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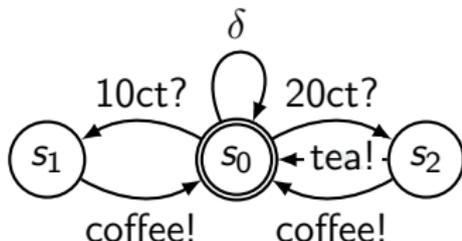
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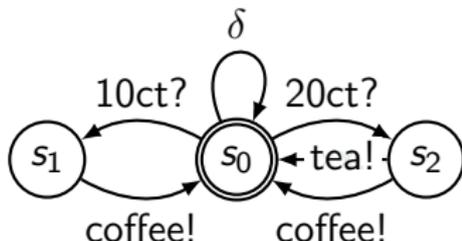
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$$w(\epsilon) = 10$$

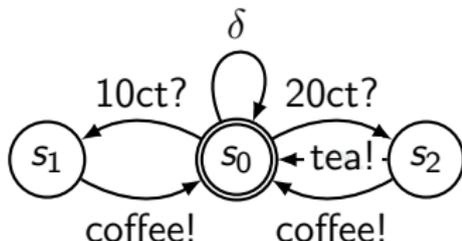
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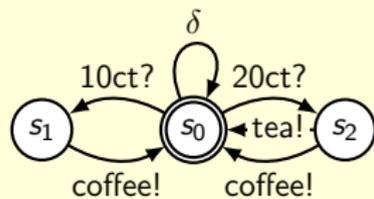
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(For more details see TechRep)

The WFS Model – Fault Weight

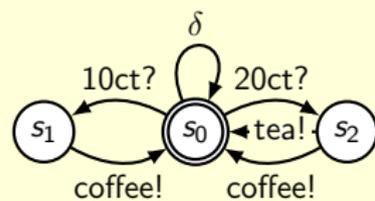
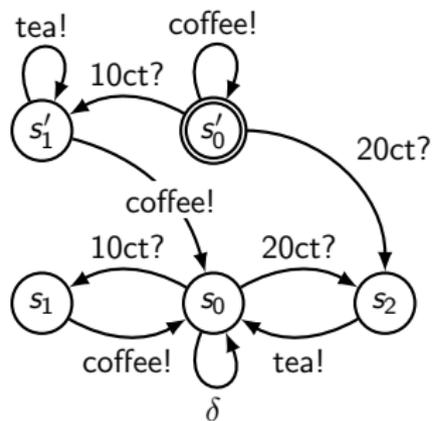


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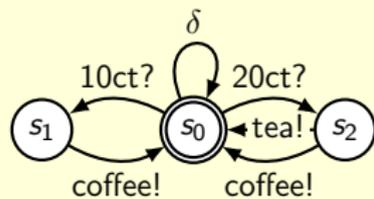
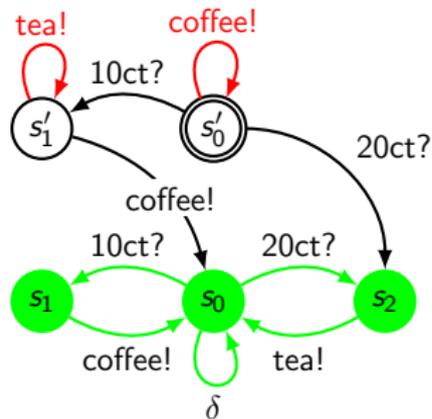


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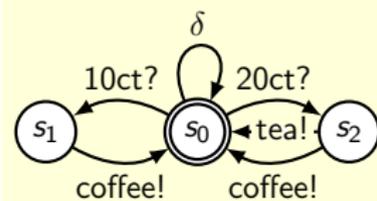
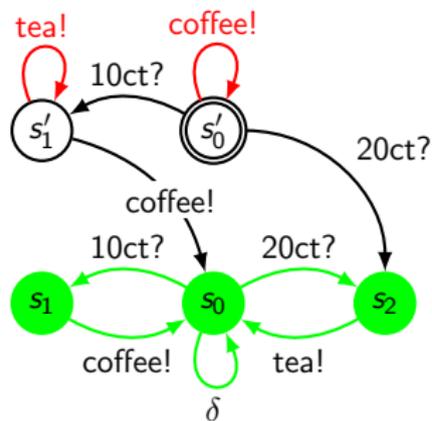


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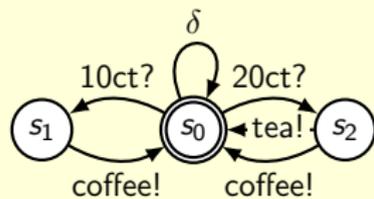
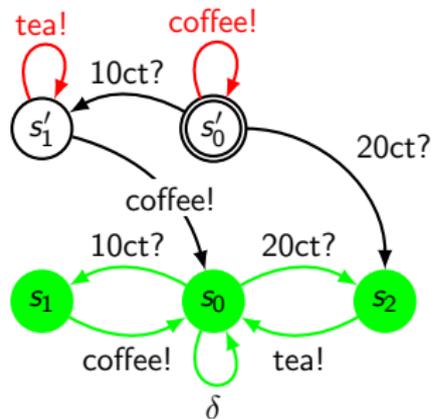
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Fault weight: $10 + 15 = 25$

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Fault weight: $10 + 15 = 25$

(We are only interested in whether a fault can occur, not in which one)

Definition

Given a test suite T and a passing execution E , we define

$$\text{risk}(T, E) = \mathbb{E}[w(\text{Impl}) \mid \text{observe } E]$$

i.e., the fault weight still expected to be present after observing E .

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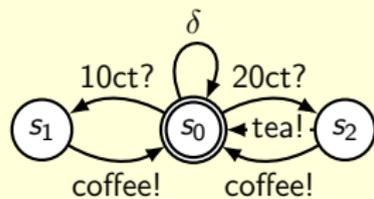
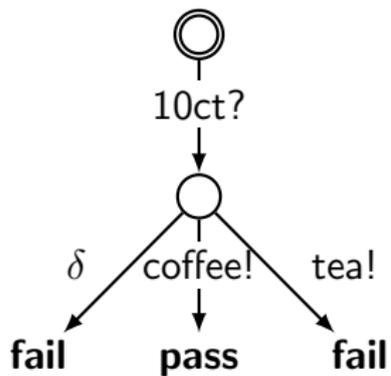
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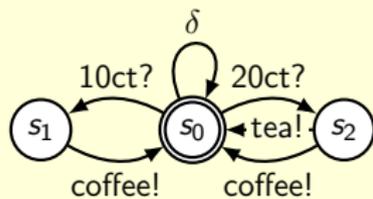
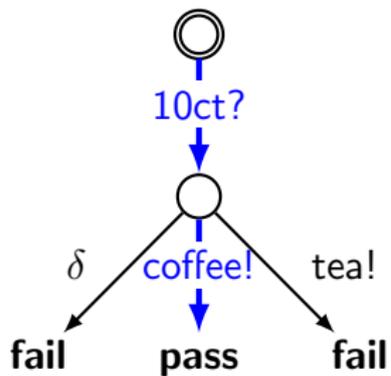
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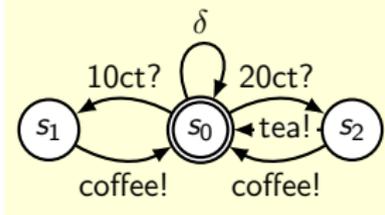
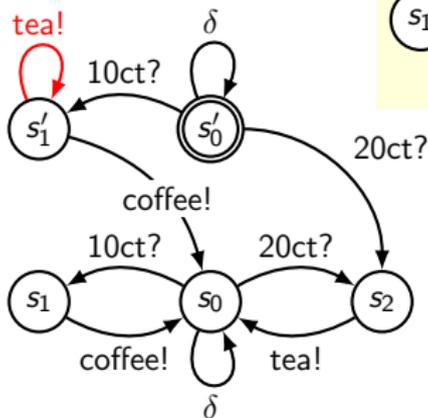
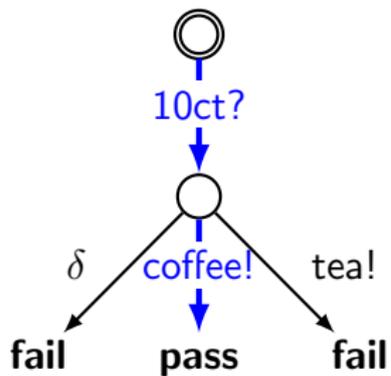
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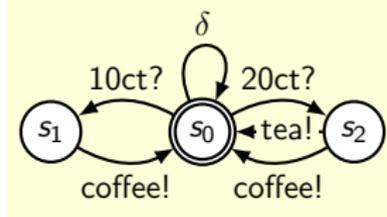
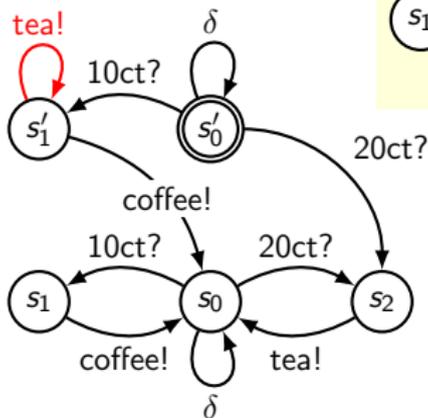
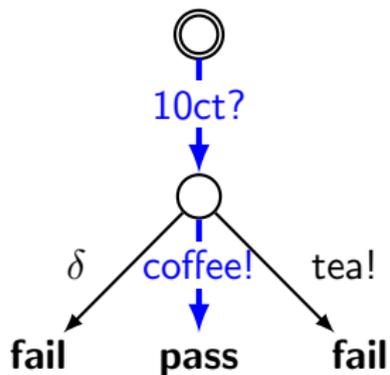
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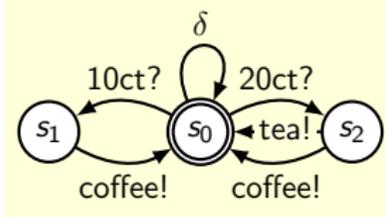
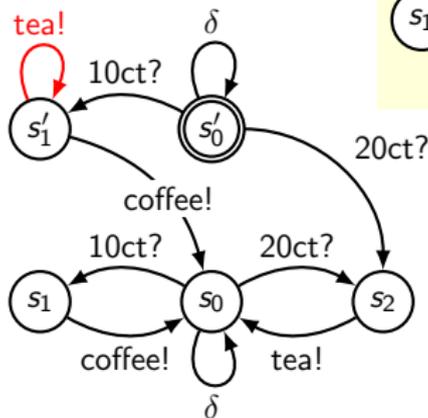
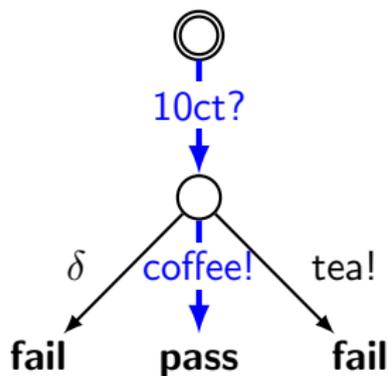






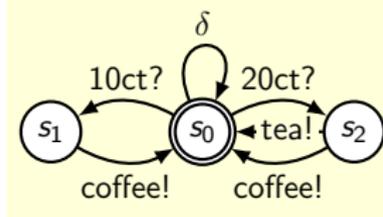
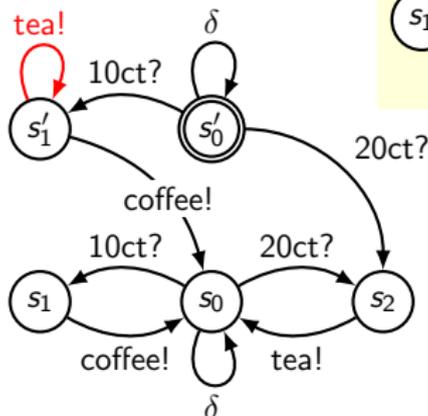
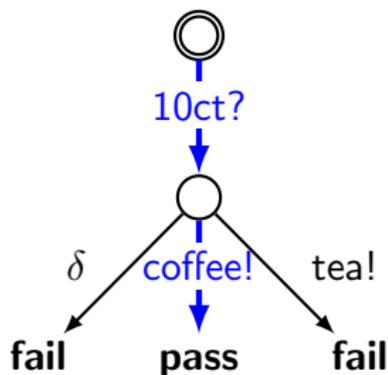


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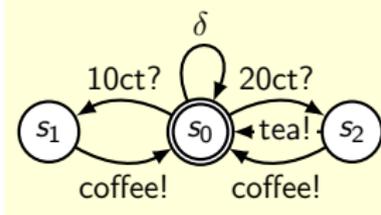
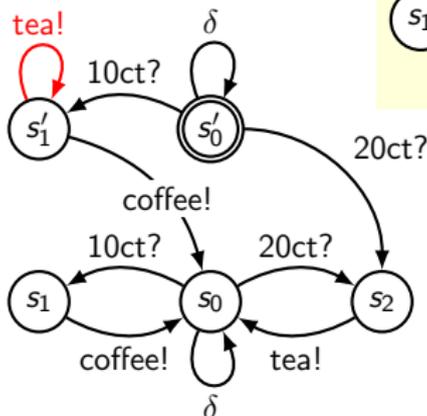
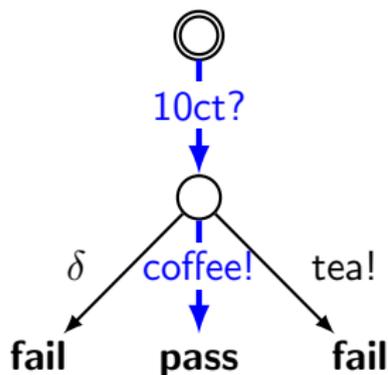
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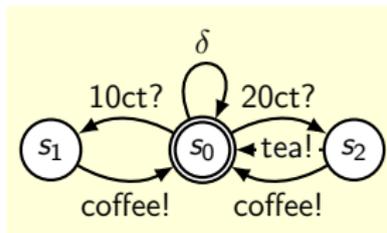
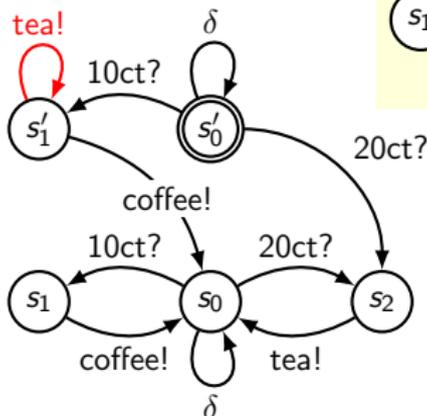
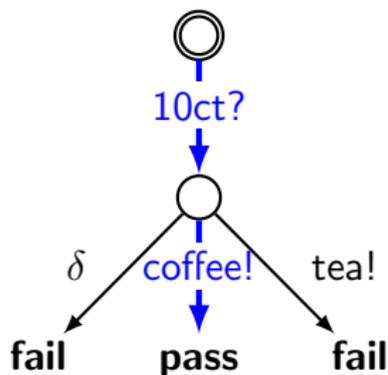
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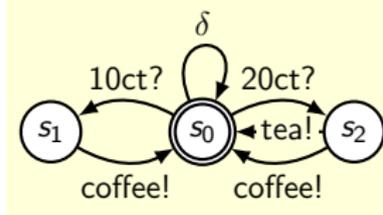
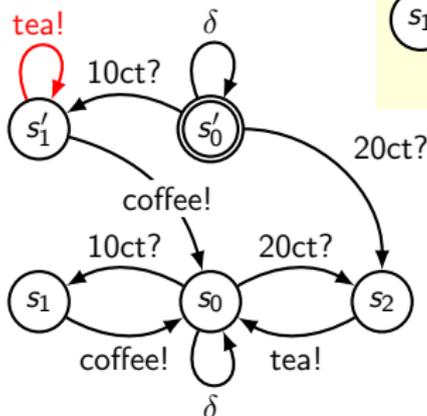
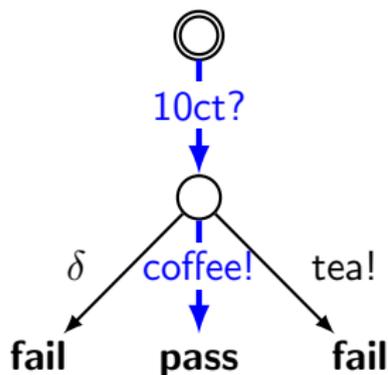
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Weighted fault specification

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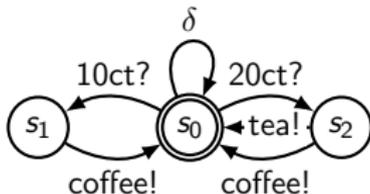
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Weighted Fault Specifications (revisited)

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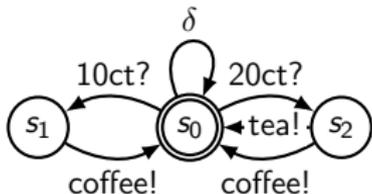


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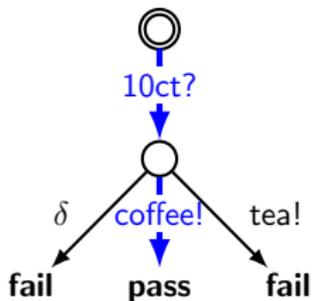
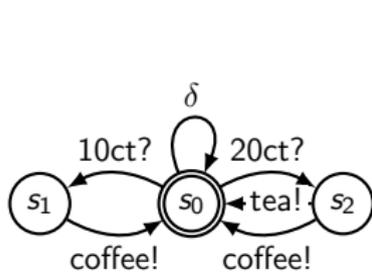
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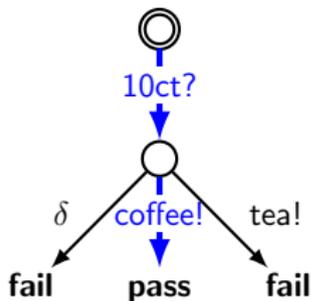
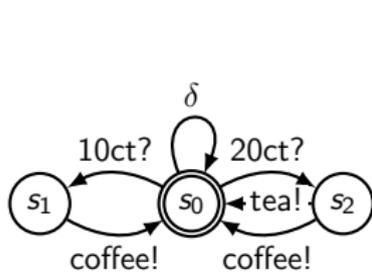
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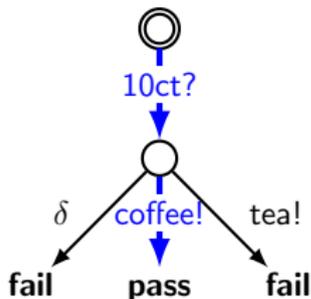
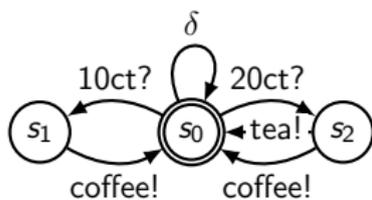


$$p_{\text{fail}}(\epsilon) = 1.0$$

$$p_{\text{fail}}(10\text{ct?}) = 0.5$$

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 $= \mathbb{P}[\text{error after } 10\text{ct?} \mid \text{correct after } 10\text{ct? once}]$

$$\mathbb{P}[A | B] = \frac{\mathbb{P}[B|A] \cdot \mathbb{P}[A]}{\mathbb{P}[B]}$$



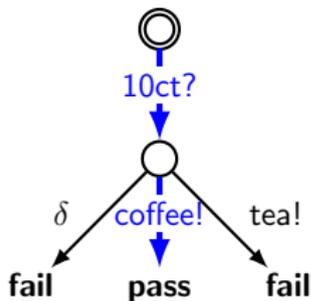
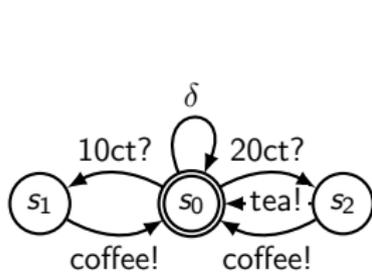
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$\stackrel{\text{Bayes}}{=} \frac{\mathbb{P}[\text{correct after } 10ct? \text{ once} \mid \text{error after } 10ct?] \cdot \mathbb{P}[\text{error after } 10ct?]}{\mathbb{P}[\text{correct after } 10ct? \text{ once}]}$



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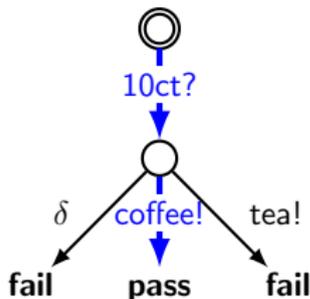
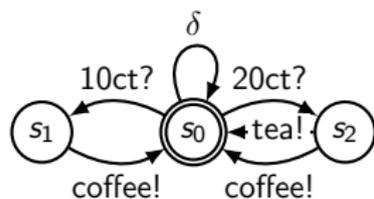
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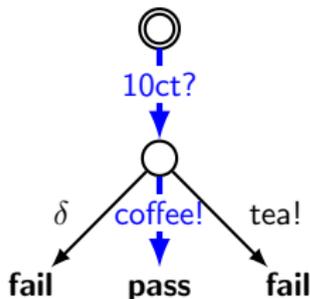
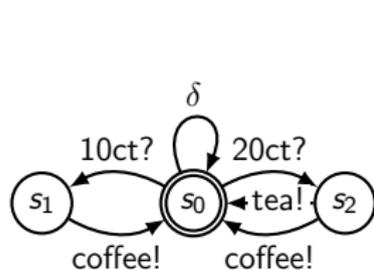
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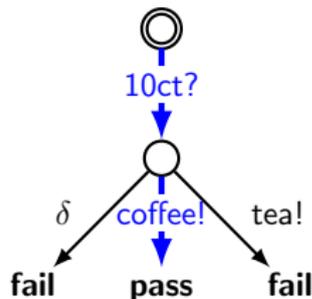
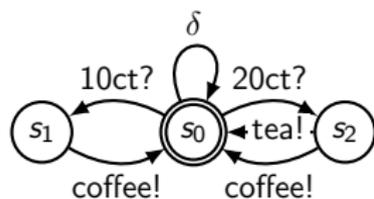
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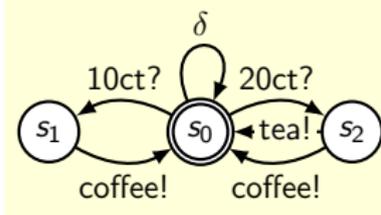
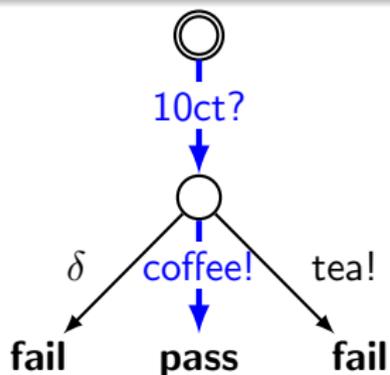
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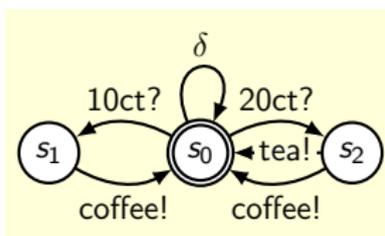
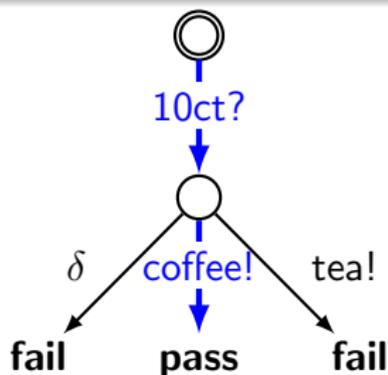
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$\text{risk}(T, E)$

$$= \sum_{\sigma \neq 10\text{ct?}} w(\sigma) \cdot p_{\text{err}}(\sigma) + w(10\text{ct?}) \cdot \mathbb{P}[\text{error after } 10\text{ct?} \mid E]$$

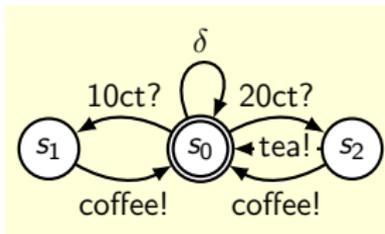
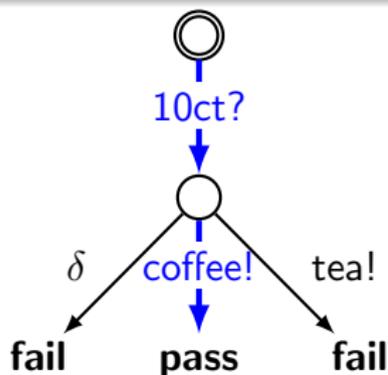


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$$\text{risk}(T, E) = \mathbb{E}[w(\text{Impl}) \mid \text{observe } E]$$

Calculation of risk

$$\text{risk}(T, E) = \text{risk}(\langle \rangle, \langle \rangle) - \sum_{\sigma \in E} w(\sigma) \cdot \left(p_{\text{err}}(\sigma) - \frac{(1 - p_{\text{fail}}(\sigma))^{\text{obs}(\sigma, E)} \cdot p_{\text{err}}(\sigma)}{(1 - p_{\text{fail}}(\sigma))^{\text{obs}(\sigma, E)} \cdot p_{\text{err}}(\sigma) + 1 - p_{\text{err}}(\sigma)} \right)$$

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Although $\text{risk}(\langle \rangle, \langle \rangle) = \sum_{\sigma} w(\sigma) \cdot p_{\text{err}}(\sigma)$ seems infinite, it can be calculated smartly:

- w defined by truncation: the sum is already finite
- w defined by discounting: system of linear equations

Optimisations

- Find the optimal test suite of a given size
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Actual Coverage

- Only consider the traces that were actually tested
- Use error probability reduction as coverage measure
- Methods very similar to risk

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- We facilitate sensitivity analysis
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It looks like we need many probabilities and weights, but

- The framework can be applied at higher levels of abstraction
- Compute risk based on error / failure probabilities of modules

Main results

- Formal notion of risk
- Both evaluation of risk *and* computation of optimal test suite
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For more details, see the technical report
(<http://fmt.cs.utwente.nl/~timmer>)

Questions

